

Notice of References Cited	Application/Control No. 10/727,781		Applicant(s)/Patent Under Reexamination GRAY ET AL.	
	Examiner Bryce P. Bonzo		Art Unit 2113	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,073,968 A	12-1991	Morrison, Robert D.	703/26
*	B	US-5,132,972 A	07-1992	Hansen, Robert G.	714/38
*	C	US-6,006,028 A	12-1999	Aharon et al.	703/21
*	D	US-6,081,885 A	06-2000	Deao et al.	712/227
*	E	US-6,075,937 A	06-2000	Scalzi et al.	703/23
*	F	US-6,094,729 A	07-2000	Mann, Daniel P.	714/25
*	G	US-6,112,298 A	08-2000	Deao et al.	712/227
*	H	US-2003/0135844 A1	07-2003	Yellin et al.	717/126
*	I	US-6,647,513 B1	11-2003	Hekmatpour, Amir	714/37
*	J	US-2004/0268327 A1	12-2004	Burger, Julian	717/140
*	K	US-6,871,298 B1	03-2005	Cavanaugh et al.	714/33
*	L	US-2005/0154550 A1	07-2005	Singh et al.	702/108
*	M	US-2006/0101369 A1	05-2006	Wang et al.	716/017

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chandra et al "AVPGEN-A Test Generator for Architecture Verification" IEEE 1995
	V	Corno et al "Automatic Test Program Generation: A Case Study" IEEE 2004
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0145896 A1	07-2006	Venkatesan et al.	341/050
*	B	US-2006/0259878 A1	11-2006	Killian et al.	716/001
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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	P					
	Q					
	R					
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	X	

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